


<b>Search Notes</b> 	<b>Application/Control No.</b> 10562626	<b>Applicant(s)/Patent Under Reexamination</b> TAKENAKA ET AL.
	<b>Examiner</b> CHRISTINE M BEHNCKE	<b>Art Unit</b> 3661

SEARCHED			
Class	Subclass	Date	Examiner
700	44, 46, 245, 250	9/29/2009	CMB
318	568.12, 568.2, 568.22	9/29/2009	CMB
901	1, 50	9/30/2009	CMB

SEARCH NOTES			
Search Notes		Date	Examiner
EAST text search		9/30/2009	CMB
Nonpatent literature search		9/30/2009	CMB

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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